

# IRG4PH40UD2

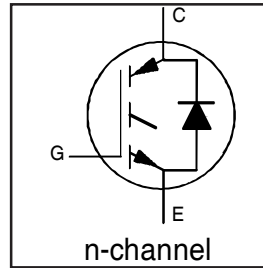
INSULATED GATE BIPOLAR TRANSISTOR WITH ULTRAFAST SOFT RECOVERY DIODE      UltraFast CoPack IGBT

## Features

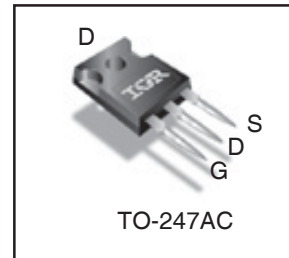
- UltraFast: Optimized for high operating frequencies up to 40 kHz in hard switching, >200 kHz in resonant mode
- New IGBT design provides tighter parameter distribution and higher efficiency than previous generations
- IGBT co-packaged with HEXFRED™ ultrafast, ultra-soft-recovery anti-parallel diodes for use in bridge configurations
- Industry standard TO-247AC package

## Benefits

- Higher switching frequency capability than competitive IGBTs
- Highest efficiency available
- HEXFRED diodes optimized for performance with IGBT's. Minimized recovery characteristics require less/no snubbing.



$V_{CES} = 1200V$
$V_{CE(on) typ.} = 1.72V$
@ $V_{GE} = 15V, I_C = 20A$



G	D	S
Gate	Drain	Source

## Absolute Maximum Ratings

	Parameter	Max.	Units
$V_{CES}$	Collector-to-Emitter Voltage	1200	V
$I_C @ T_C = 25^\circ C$	Continuous Collector Current	40	A
$I_C @ T_C = 100^\circ C$	Continuous Collector Current	20	
$I_{CM}$	Pulse Collector Current ①	160	
$I_{LM}$	Clamped Inductive Load current ①	160	
$I_F @ T_C = 100^\circ C$	Diode Continuous Forward Current	10	
$I_{FM}$	Diode Maximum Forward Current	40	W
$V_{GE}$	Gate-to-Emitter Voltage	$\pm 20$	
$P_D @ T_C = 25^\circ C$	Maximum Power Dissipation	160	W
$P_D @ T_C = 100^\circ C$	Maximum Power Dissipation	65	
$T_J$	Operating Junction and	-55 to +150	°C
$T_{STG}$	Storage Temperature Range		
	Storage Temperature Range, for 10 sec.	300 (0.063 in. (1.6mm) from case)	
	Mounting Torque, 6-32 or M3 screw	10 lbf•in (1.1N•m)	

## Thermal / Mechanical Characteristics

	Parameter	Min.	Typ.	Max.	Units
$R_{\theta JC}$	Junction-to-Case- IGBT	—	—	0.77	°C/W
$R_{\theta JC}$	Junction-to-Case- Diode	—	—	2.5	
$R_{\theta CS}$	Case-to-Sink, flat, greased surface	—	0.24	—	
$R_{\theta JA}$	Junction-to-Ambient, typical socket mount	—	—	40	
Wt	Weight	—	6 (0.21)	—	g (oz.)

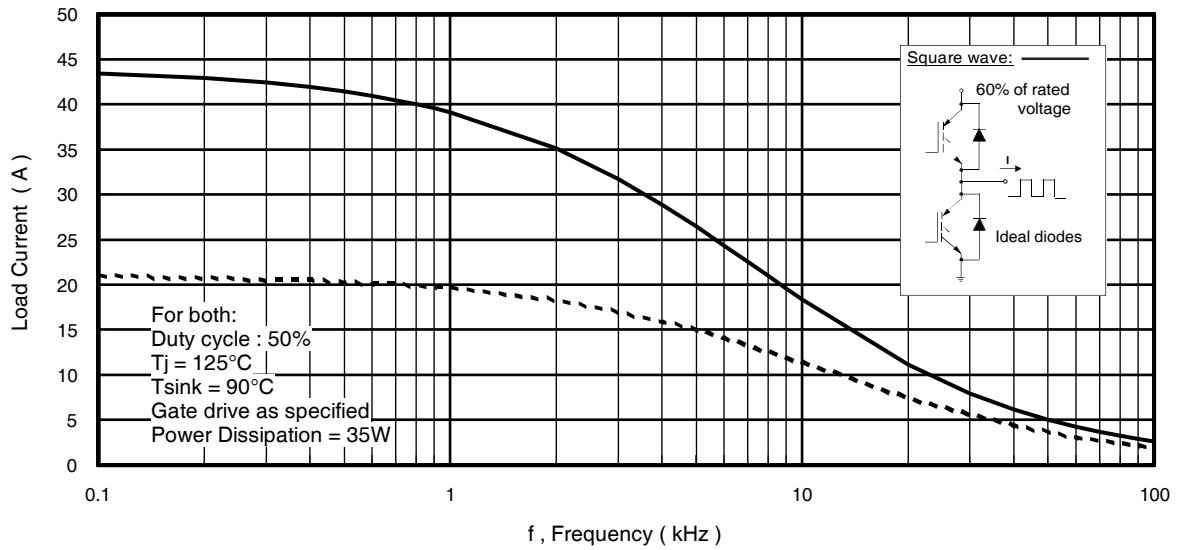
# IRG4PH40UD2

## Electrical Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

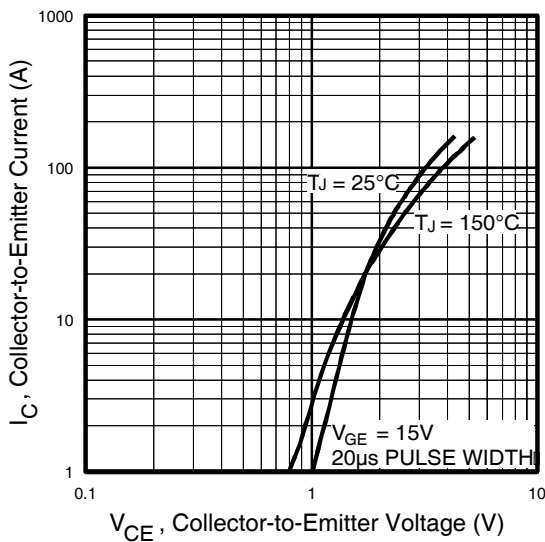
Parameter	Min.	Typ.	Max.	Units	Conditions	
V <sub>(BR)CES</sub>	1200	—	—	V	V <sub>GE</sub> = 0V, I <sub>C</sub> = 250μA	
ΔV <sub>(BR)CES</sub> /ΔT <sub>J</sub>	—	0.63	—	V/°C	V <sub>GE</sub> = 0V, I <sub>C</sub> = 1mA (25°C-150°C)	
V <sub>CE(on)</sub>	Collector-to-Emitter Saturation Voltage	—	1.72	2.1	V	I <sub>C</sub> = 20A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 25°C
		—	2.15	—		I <sub>C</sub> = 40A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 125°C
		—	1.7	—		I <sub>C</sub> = 20A, V <sub>GE</sub> = 15V, T <sub>J</sub> = 150°C
V <sub>GE(th)</sub>	3.0	—	6.0		V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA	
ΔV <sub>GE(th)</sub> /ΔT <sub>J</sub>	—	-13	—	mV/°C	V <sub>CE</sub> = V <sub>GE</sub> , I <sub>C</sub> = 250μA	
g <sub>fe</sub>	11	18	—	S	V <sub>CE</sub> = 100V, I <sub>C</sub> = 20A	
I <sub>CES</sub>	Zero Gate Voltage Collector Current	—	—	250	μA	V <sub>GE</sub> = 0V, V <sub>CE</sub> = 1200V
		—	—	2.0		V <sub>GE</sub> = 0V, V <sub>CE</sub> = 10V, T <sub>J</sub> = 25°C
		—	—	2500		V <sub>GE</sub> = 0V, V <sub>CE</sub> = 1200V, T <sub>J</sub> = 150°C
V <sub>FM</sub>	Diode Forward Voltage Drop	—	3.4	3.8	V	I <sub>F</sub> = 10A, V <sub>GE</sub> = 0V
		—	3.3	3.7		I <sub>F</sub> = 10A, V <sub>GE</sub> = 0V, T <sub>J</sub> = 150°C
I <sub>GES</sub>	Gate-to-Emitter Leakage Current	—	—	±100	nA	V <sub>GE</sub> = ±20V

## Switching Characteristics @ T<sub>J</sub> = 25°C (unless otherwise specified)

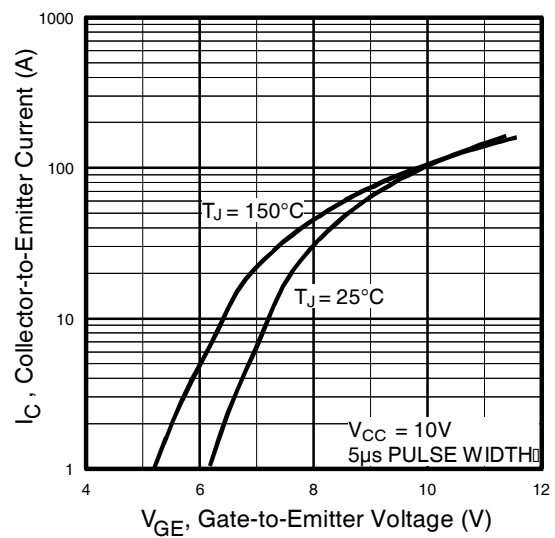
Parameter	Min.	Typ.	Max.	Units	Conditions	
Q <sub>g</sub>	—	110	130	nC	I <sub>C</sub> = 20A V <sub>CC</sub> = 400V V <sub>GE</sub> = 15V	
Q <sub>ge</sub>	—	18	24			
Q <sub>gc</sub>	—	36	53			
t <sub>d(on)</sub>	—	23	—	ns	I <sub>C</sub> = 20A, V <sub>CC</sub> = 600V V <sub>GE</sub> = 15V, R <sub>G</sub> = 10Ω T <sub>J</sub> = 25°C Energy losses included "tail"	
t <sub>r</sub>	—	27	—			
t <sub>d(off)</sub>	—	100	110			
t <sub>f</sub>	—	280	340			
E <sub>on</sub>	—	1440	—	μJ	I <sub>C</sub> = 20A, V <sub>CC</sub> = 600V V <sub>GE</sub> = 15V, R <sub>G</sub> = 10Ω T <sub>J</sub> = 25°C	
E <sub>off</sub>	—	1410	—			
E <sub>tot</sub>	—	2850	3740			
t <sub>d(on)</sub>	—	22	—	ns	I <sub>C</sub> = 20A, V <sub>CC</sub> = 600V V <sub>GE</sub> = 15V, R <sub>G</sub> = 10Ω, L = 1.0mH T <sub>J</sub> = 150°C Energy losses included "tail"	
t <sub>r</sub>	—	32	—			
t <sub>d(off)</sub>	—	190	—			
t <sub>f</sub>	—	630	—			
E <sub>TS</sub>	—	5360	—	μJ		
L <sub>E</sub>	—	13	—	nH	Measured 5mm from package	
C <sub>ies</sub>	—	2100	—	pF	V <sub>GE</sub> = 0V V <sub>CC</sub> = 30V f = 1.0MHz	
C <sub>oes</sub>	—	99	—			
C <sub>res</sub>	—	12	—			
t <sub>rr</sub>	Diode Reverse Recovery Time	—	50	76	ns	T <sub>J</sub> =25°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
		—	72	110		T <sub>J</sub> =125°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
I <sub>rr</sub>	Diode Peak Reverse Recovery Current	—	4.4	7.0	A	T <sub>J</sub> =25°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
		—	5.9	8.8		T <sub>J</sub> =125°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
Q <sub>rr</sub>	Diode Reverse Recovery Charge	—	130	200	nC	T <sub>J</sub> =25°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
		—	250	380		T <sub>J</sub> =125°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
di <sub>(rec)</sub> M/dt	Diode Peak Rate of Fall of Recovery During t <sub>b</sub>	—	210	—	A/μs	T <sub>J</sub> =25°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs
		—	180	—		T <sub>J</sub> =125°C, V <sub>CC</sub> = 200V, I <sub>F</sub> = 10A, di/dt = 200A/μs



**Fig. 1 - Typical Load Current vs. Frequency**  
 (Load Current =  $I_{\text{RMS}}$  of fundamental)

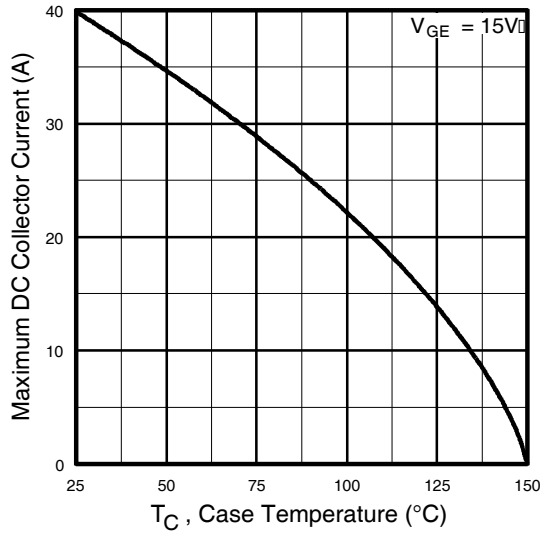


**Fig. 2 - Typical Output Characteristics**

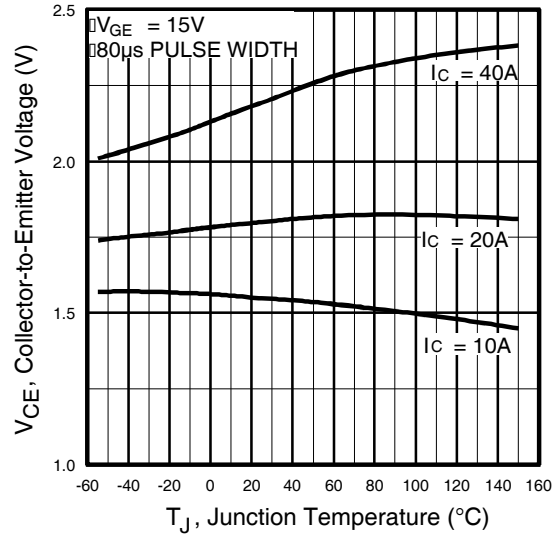


**Fig. 3 - Typical Transfer Characteristics**

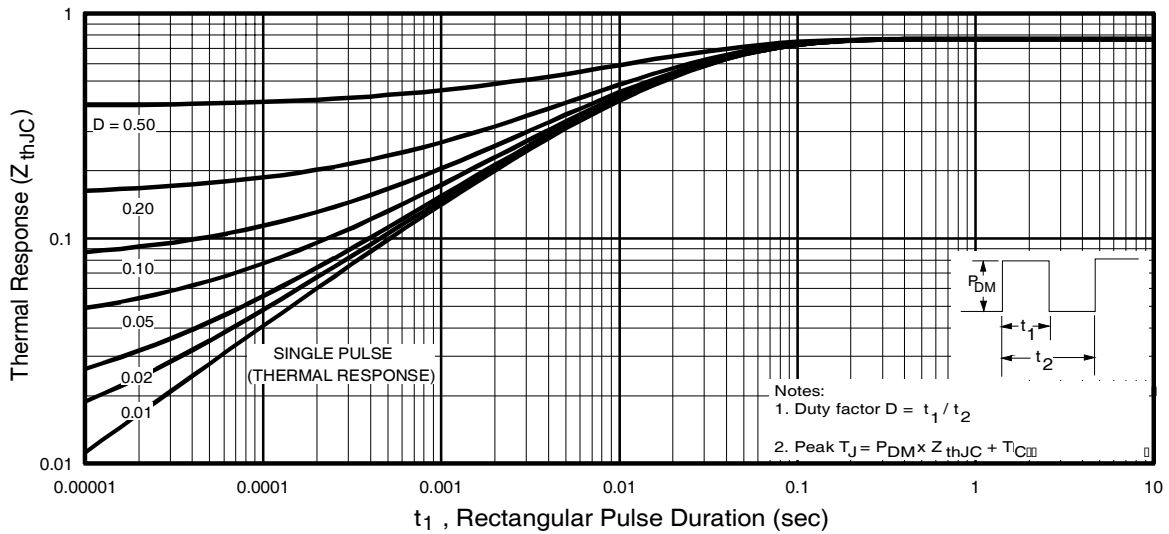
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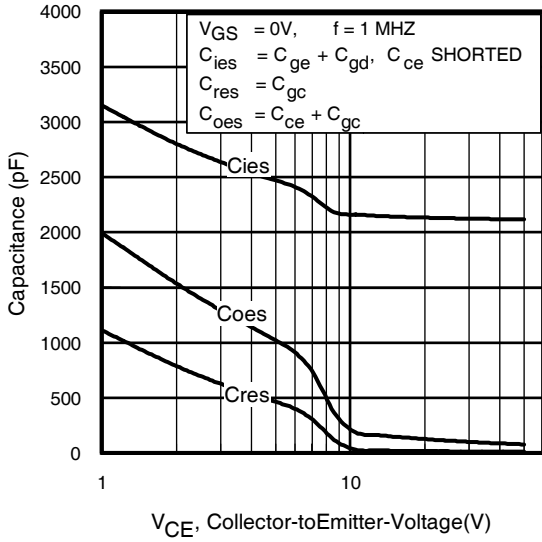
**Fig. 4 - Maximum Collector Current vs. Case Temperature**



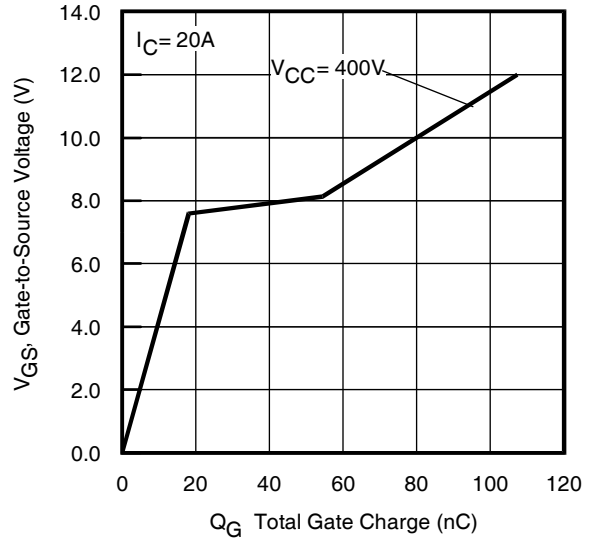
**Fig. 5 - Typical Collector-to-Emitter Voltage vs. Junction Temperature**



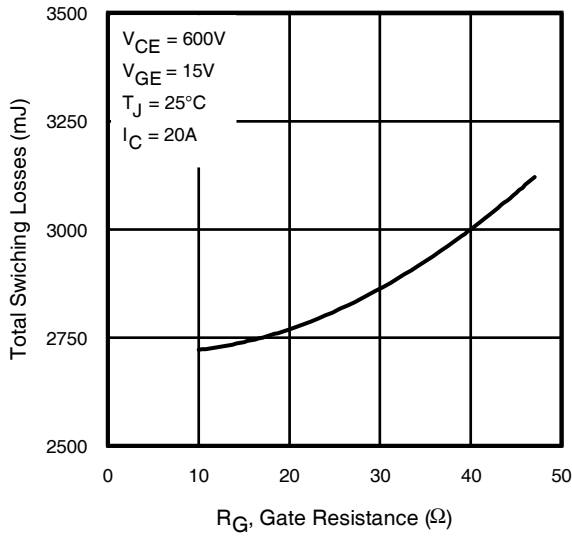
**Fig. 6 - Maximum Effective Transient Thermal Impedance, Junction-to-Case**



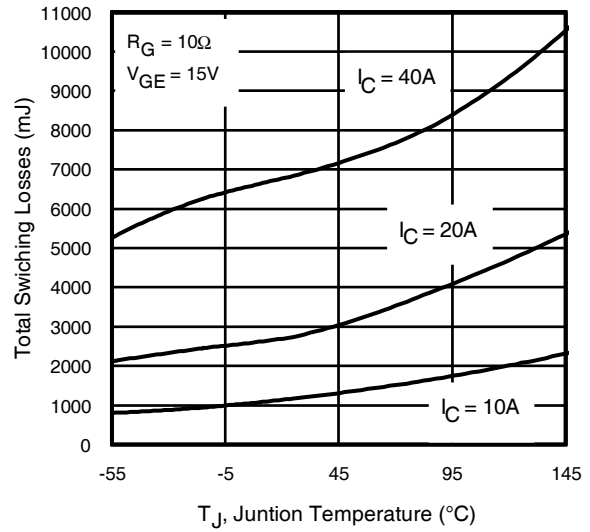
**Fig. 7 - Typical Capacitance vs. Collector-to-Emitter Voltage**



**Fig. 8 - Typical Gate Charge vs. Gate-to-Source Voltage**

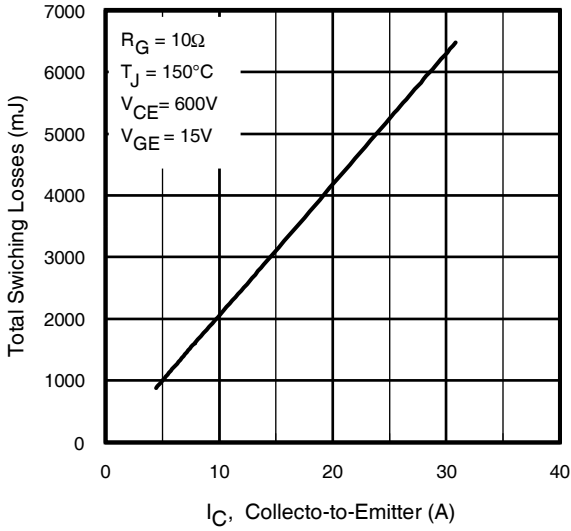


**Fig. 9 - Typical Switching Losses vs. Gate Resistance**

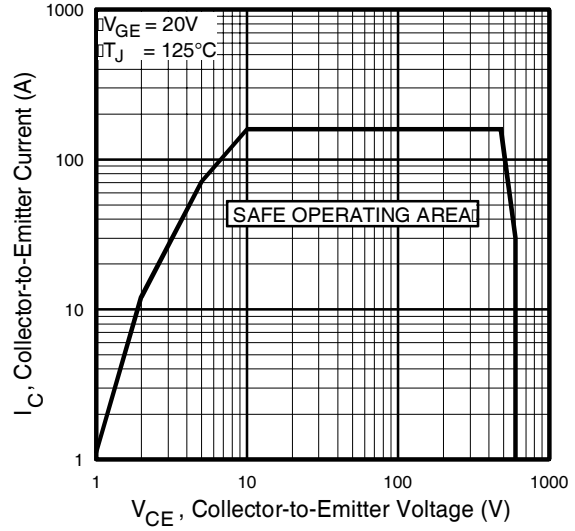


**Fig. 10 - Typical Switching Losses vs. Junction Temperature**

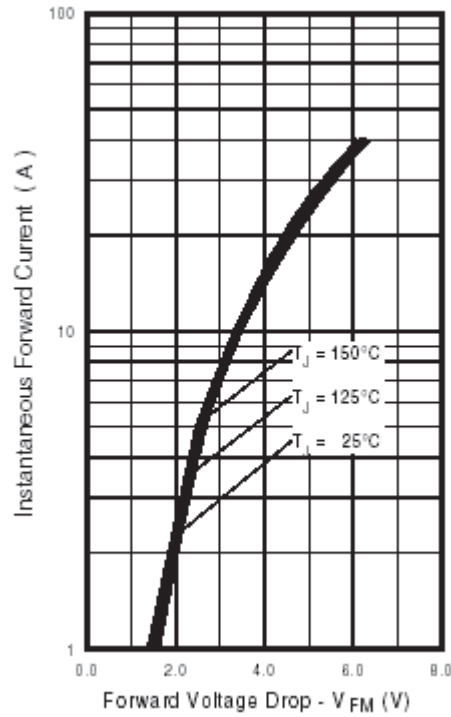
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**Fig. 11** - Typical Switching Losses vs. Collector-to-Emitter Current



**Fig. 12** - Turn-Off SOA



**Fig. 13** - Maximum Forward Voltage Drop vs. Instantaneous Forward Current

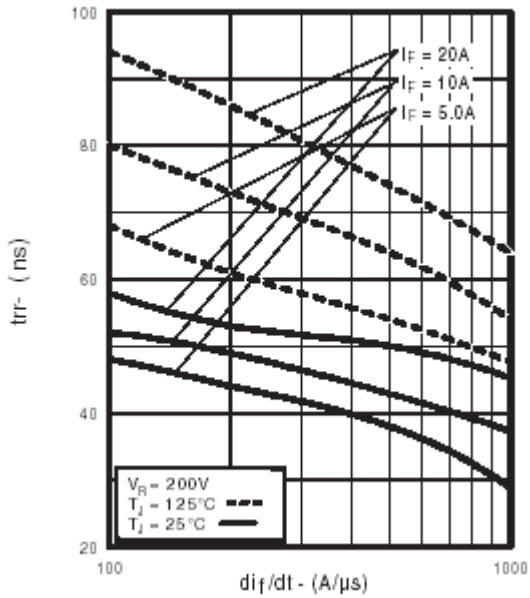


Fig. 14 - Typical Reverse Recovery vs.  $di_f/dt$

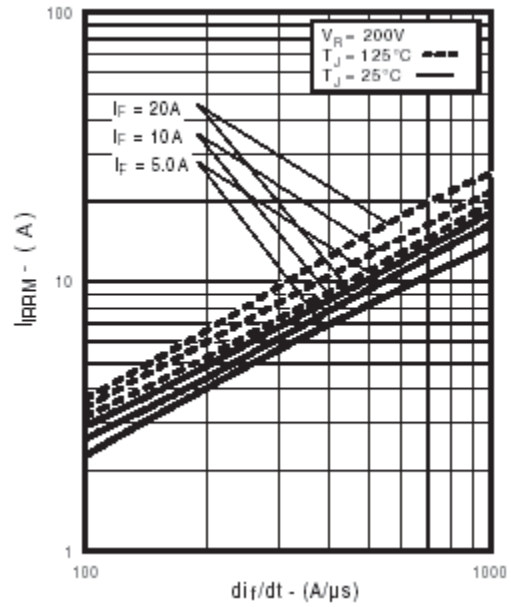


Fig. 15 - Typical Recovery Current vs.  $di_f/dt$

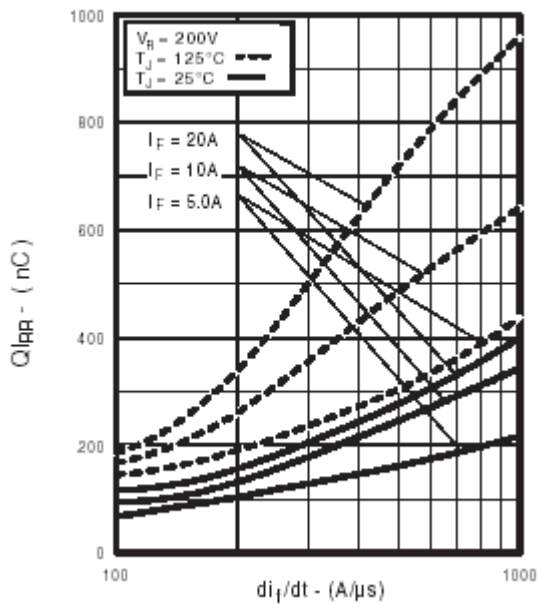


Fig. 16 - Typical Stored Charge vs.  $di_f/dt$

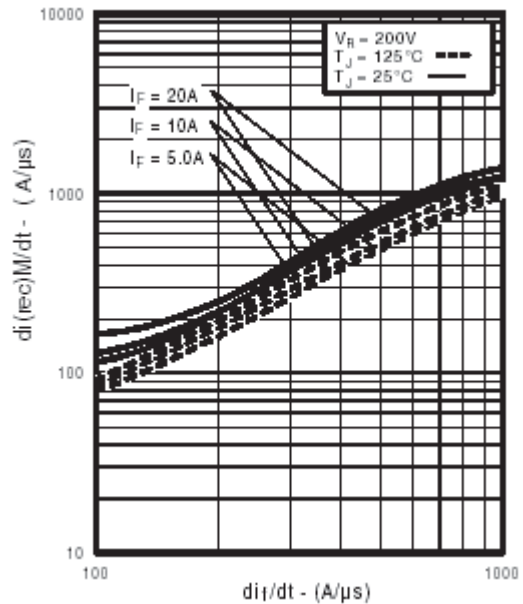
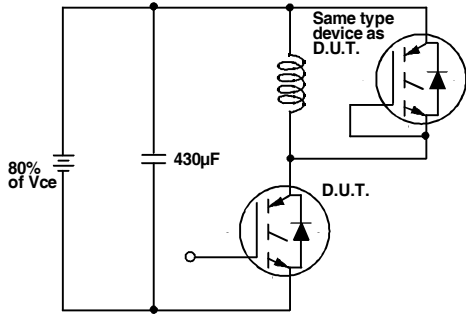
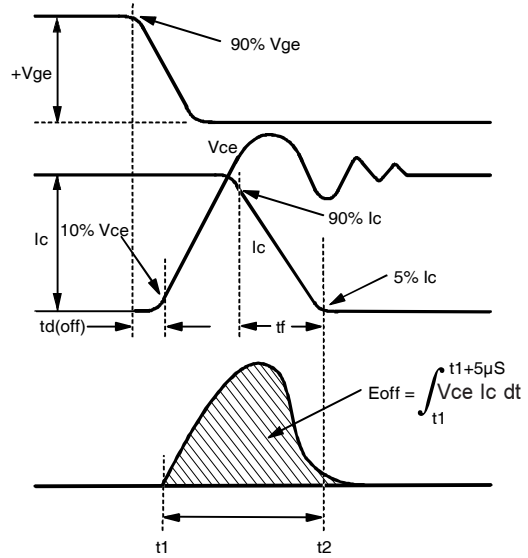


Fig. 17 - Typical  $di_{(rec)M}/dt$  vs.  $di_f/dt$

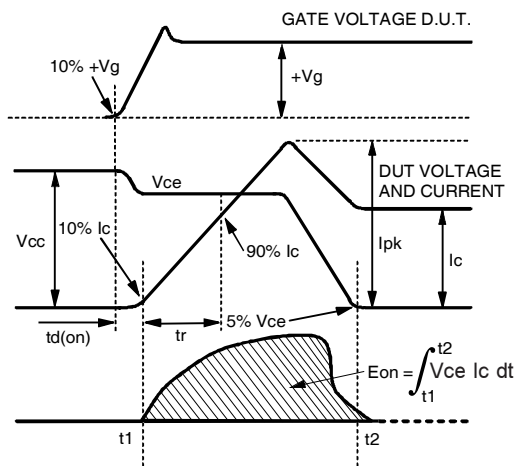
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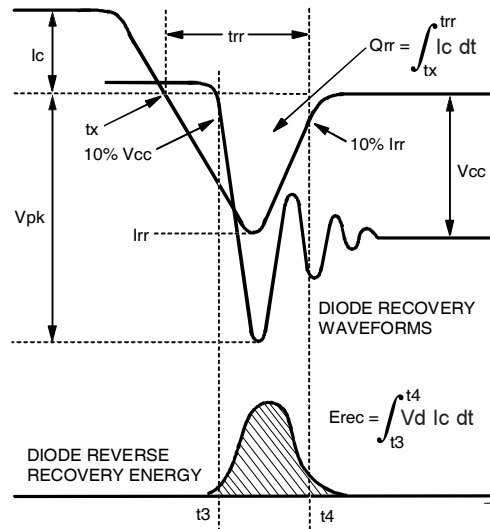
**Fig. 18a** - Test Circuit for Measurement of  $I_{LM}$ ,  $E_{on}$ ,  $E_{off}(\text{diode})$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$ ,  $t_{d(on)}$ ,  $t_r$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18b** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{off}$ ,  $t_{d(off)}$ ,  $t_f$



**Fig. 18c** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{on}$ ,  $t_{d(on)}$ ,  $t_r$



**Fig. 18d** - Test Waveforms for Circuit of Fig. 18a, Defining  $E_{rec}$ ,  $t_{rr}$ ,  $Q_{rr}$ ,  $I_{rr}$



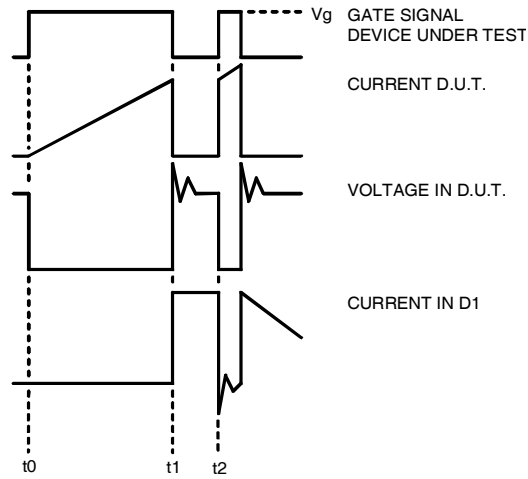


Figure 18e. Macro Waveforms for Figure 18a's Test Circuit

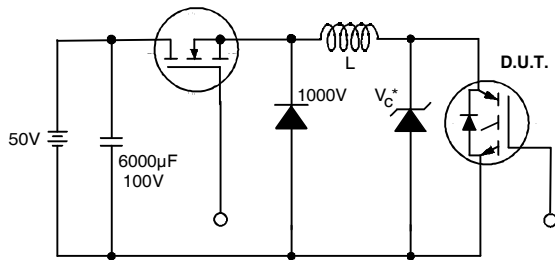


Figure 19. Clamped Inductive Load Test Circuit

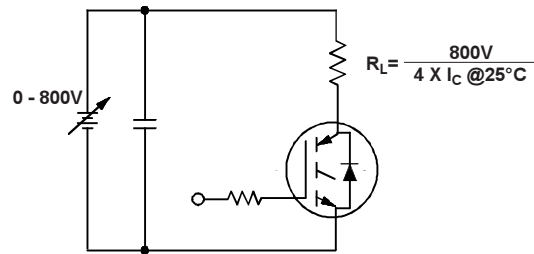


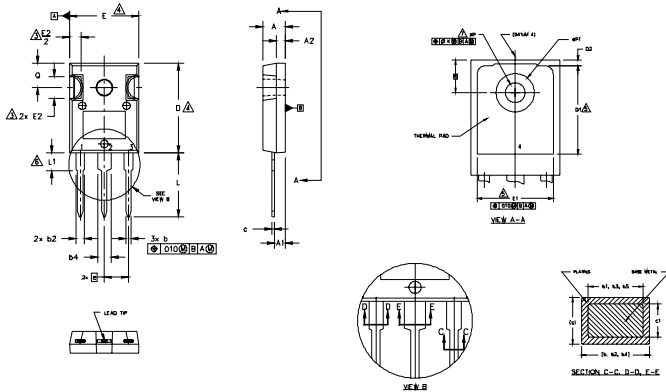
Figure 20. Pulsed Collector Current Test Circuit

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## TO-247AC Package Outline



Dimensions are shown in millimeters (inches)



- NOTES:
1. DIMENSIONING AND TOLERANCING AS PER ASME Y14.5M 1994.
  2. DIMENSIONS ARE SHOWN IN INCHES.
  3. CONTOUR OF SLOT OPTIONAL.
  4. DIMENSION D & E DO NOT INCLUDE MOLD FLASH. MOLD FLASH SHALL NOT EXCEED .005" (0.127) PER SIDE. THESE DIMENSIONS ARE MEASURED AT THE OUTERMOST EXTREMES OF THE PLASTIC BODY.
  5. THERMAL PAD CONTOUR OPTIONAL WITHIN DIMENSIONS D1 & E1.
  6. LEAD FINISH UNCONTROLLED IN LT.
  7. #P TO HAVE A MAXIMUM DRAFT ANGLE OF 1.5 ° TO THE TOP OF THE PART WITH A MAXIMUM HOLE DIAMETER OF .154 INCH.
  8. OUTLINE CONFORMS TO JEDEC OUTLINE TO-247AC.

SYMBOL	DIMENSIONS				NOTES
	INCHES		MILLIMETERS		
	MIN.	MAX.	MIN.	MAX.	
A	.183	.209	4.65	5.31	
A1	.087	.102	2.21	2.59	
A2	.059	.098	1.50	2.49	
b	.039	.055	0.99	1.40	
b1	.039	.053	0.99	1.35	
b2	.065	.094	1.65	2.39	
b3	.065	.092	1.65	2.34	
b4	.102	.135	2.59	3.43	
b5	.102	.135	2.59	3.38	
c	.015	.035	0.38	0.89	
e1	.015	.033	0.38	0.84	4
D	.778	.815	19.71	20.70	5
D1	.515	-	13.06	-	
D2	.020	.053	0.51	1.35	4
E	.602	.625	15.29	15.87	
E1	.500	-	12.70	-	
E2	.178	.216	4.52	5.49	
e	.215 BSC				5.46 BSC
W	.010				0.25
L	.059	.634	14.20	16.10	
L1	.146	.169	3.71	4.29	
#P	.140	.144	3.56	3.66	
#PH	-	.291	-	7.39	
Q	.209	.224	5.31	5.69	
S	.217 BSC				5.51 BSC

### LEAD ASSIGNMENTS

- HEXFET
- 1.- GATE
  - 2.- DRAIN
  - 3.- SOURCE
  - 4.- DRAIN

### IGBTs, COPACK

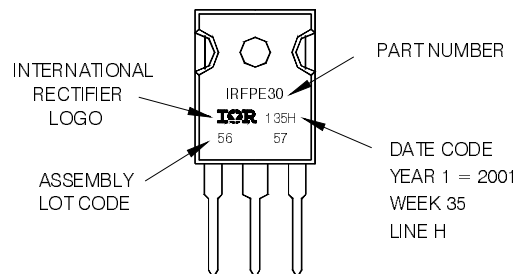
- 1.- GATE
- 2.- COLLECTOR
- 3.- EMITTER
- 4.- COLLECTOR

- DIODES
- 1.- ANODE/OPEN
  - 2.- CATHODE
  - 3.- ANODE

## TO-247AC Part Marking Information

EXAMPLE: THIS IS AN IRFPE30  
WITH ASSEMBLY  
LOT CODE 5657  
ASSEMBLED ON VW 35, 2001  
IN THE ASSEMBLY LINE "H"

Note: "P" in assembly line position  
indicates "Lead-Free"



**TO-247AC package is not recommended for Surface Mount Application.**

### Notes:

- ① Repetitive rating:  $V_{GE}=20V$ ; pulse width limited by maximum junction temperature (figure 20)
- ②  $V_{CC}=80\%(V_{CES})$ ,  $V_{GE}=20V$ ,  $L=10\mu H$ ,  $R_G=10\Omega$  (figure 19)
- ③ Pulse width  $\leq 80\mu s$ ; duty factor  $\leq 0.1\%$ .
- ④ Pulse width  $5.0\mu s$ , single shot.

Data and specifications subject to change without notice.  
This product has been designed and qualified for industrial market.  
Qualification Standards can be found on IR's Web site.



**IR WORLD HEADQUARTERS:** 233 Kansas St., El Segundo, California 90245, USA Tel: (310) 252-7105  
TAC Fax: (310) 252-7903  
Visit us at [www.irf.com](http://www.irf.com) for sales contact information. 01/06

Note: For the most current drawings please refer to the IR website at:  
<http://www.irf.com/package/>